

Attorney's Docket No.: 00784C5-149004

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Birang, et al. Art Unit: 3723

Serial No.: 09/863,118 Examiner: Lee Wilson

Filed: May 22, 2001

Title : METHOD OF FORMING A TRANSPARENT WINDOW IN A POLISHING

**PAD** 

## **MAIL STOP RCE**

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## **INFORMATION DISCLOSURE STATEMENT**

Applicant submits the references listed on the attached form PTO-1449. The references designated AA-AC are not provided pursuant to 1276 OG 55.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: 11/12/04 Daved G-

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## CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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	Substitute Form PTO-1449  U.S. Department of Commerce (Modified)  Patent and Trademark Office		Attorney's Docket No. 00784C5-149004	Application No. 09/863,118	
	Information Disclosure Statement by Applicant (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant Birang, et al.		
			Filing Date May 22, 2001	Group Art Unit 3723	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication / Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,486,129	January 1996	Sandhu et al.			
	AB	5,672,091	September 1997	Takahashi et al.			
	AC	6,676,717	January 2004	Birang et al.			

<del>-</del> -	Foreig	n Patent Do	cuments or P	ublished Foreign	Patent A	Application	าร	
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number.	Date	Patent Office	Class	Subclass	Yes	No
	AD	02-222533	09/1990	Japan			X	
	AE	58-004353	01/1983	Japan			X	
	AF	60-037076	02/1994	Japan			X	
	AG	62-190728	08/1987	Japan			X	
	AH	62-211927	09/1987	Japan			X	
	Other D	ocuments (i	nclude Autho	or, Title, Date, and	Place o	f Publicati	on)	
Examiner Initial	Desig. ID	,		Document				
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EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with				

next communication to applicant.